

# Structural, optical and ferroelectric properties of V doped ZnO

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**Abstract** Present work reports the structural, optical and ferroelectric properties of vanadium doped ZnO samples synthesized via solid state reaction method. X-ray diffraction (XRD) study confirms the presence of hexagonal wurtzite phase and the slight changes in lattice parameters is observed after V doping in host ZnO and impurity oxide of  $\text{ZnV}_2\text{O}_6$ . Presence of  $E_1$  and  $E_2$  modes in Raman spectroscopy of V doped ZnO indicates the stability of the wurtzite structure of ZnO, which is consistent with the XRD results. UV–Vis spectroscopy results show decrease in band gap of ZnO from 3.35 to 3.24 eV for 1 % V doped sample, whereas it increases with the V doping and increase in the impurity of  $\text{ZnV}_2\text{O}_6$ . Furthermore, it is observed that the ferroelectric polarisation of ZnO improves by V doping. Above results show that one need to consider the presence of ZnO in composite form of oxides of Zn and V and not as a pure V doped ZnO system.

**Keywords** Zinc oxide · Raman spectroscopy · Ferroelectricity and hysteresis curve

## Introduction

Doping results in dramatic changes in the structural, optical, electrical and magnetic properties of wide band gap semiconductors. ZnO and oxides of vanadium exhibit multifunctional properties that make them interesting materials for technological applications. Zinc oxide has wide band gap (3.3 eV) and large exciton binding energy (60 meV) which makes it suitable for short wavelength optoelectronic devices (Wang 2004; Kumar et al. 2012). Doping these metal oxides enhances the magnetic, optical and semiconducting properties (Karamat et al. 2010). Vanadium doped ZnO attracted researchers because of improved electric and magnetic properties (Schlenker et al. 2007; Naydenova et al. 2010). Single phase ZnO– $\text{V}_2\text{O}_5$  system has been considered as a diluted magnetic semiconductor (DMS) material. The existence of ferromagnetism in V doped ZnO was theoretically predicted by Sato and Yoshida (2002). For electrical properties, V ions replace the  $\text{Zn}^{2+}$  site in ZnO lattice to compensate the electric charge and results in the enhancement in electron concentration of the system. The increased electron concentration gives rise to an increase in the electrical conductivity (Jin et al. 2000). Apart from the improved ferromagnetic and electrical properties, V doped ZnO exhibits good ferroelectric nature at and above room temperature, which adds an additional dimension to its applications (Schlenker et al. 2007; Naydenova et al. 2010). Till date, the ferroelectric materials used for ferroelectric memory devices are mainly based on perovskite ferroelectrics that are structurally complicated and relatively difficult to synthesize. Furthermore, some ZnO-based ferroelectric materials have also been reported. However, the problem in ZnO-based ferroelectrics (Li, Mg and Cr-doped ZnO) is their low remnant polarization and high coercive

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field (Onodera et al. 1996; Kumar et al. 2013; Dhananjay et al. 2006; Yang et al. 2008). The persistence of ferroelectric behaviour, at and above room temperature in V doped ZnO opens up new possibilities for high temperature nanopiezotronics applications and ferroelectric memory devices.

In view of the above, present study focuses the physical properties of V doped ZnO. We have synthesized pure ZnO, 1, 5 and 9 % V doped ZnO samples by solid state reaction method and studied their structural, morphological, optical and ferroelectric properties by characterising them through X-ray diffraction, Raman, UV–Vis spectroscopy and ferroelectric loop tracer.

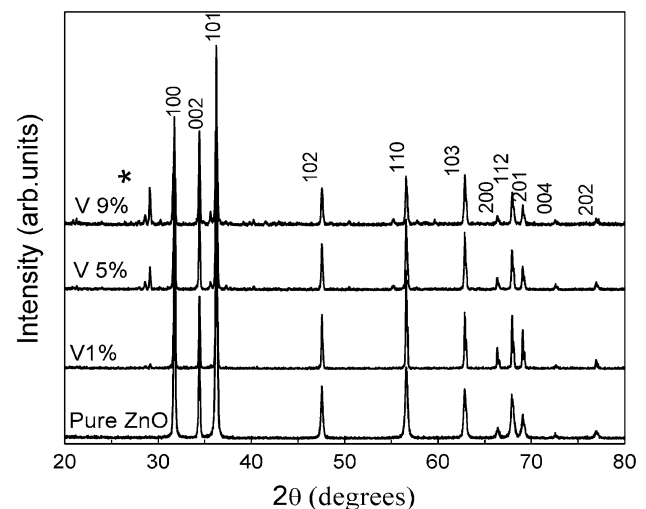
## Experimental

ZnO and 1, 5, and 9 % V doped ZnO samples were prepared by solid state reaction using  $V_2O_5$  and ZnO as initial precursors. Appropriate amount of precursors, ZnO and  $V_2O_5$  powders were mixed together and ground for 2 h for the proper mixing of powder. The ground powder was then calcined at 700 °C for 8 h, again ground and pelletized. These pellets were again sintered at 800 °C for 14 h to remove the lattice defects. The synthesized samples were characterized by various techniques for their structural, optical and ferroelectric properties. Bruker D8 X-ray Diffractometer was used for structural investigations and surface morphology was investigated using scanning electron microscope (SEM), MIRA II LMH, TESCAN. Raman spectroscopy was performed with InVia Raman microscope (Renishaw) with  $Ar^+$  ion laser beam having wavelength of 514 nm and 50 mW power. Ferroelectric hysteresis loops were measured using ferroelectric loop tracer.

## Results and discussion

### X-ray diffraction (XRD)

XRD patterns of V doped ZnO samples are shown in Fig. 1. All the diffraction peaks in the pattern can be indexed using pure wurtzite phase of ZnO with hexagonal structure (JCPDS database of card number 36-1451). It is clear from the figure that all the samples doped with different amounts of V have similar crystal structures. An impure phase corresponding to  $ZnV_2O_6$  was also found which is marked as \* in the XRD patterns for V doped ZnO samples. As evident from Fig. 1, as the concentration increases, the intensity of these peaks assigned to impurity phases also increases. The same phases are also found at all higher doping levels of V. There is a slight variation in the lattice parameter 'a' whereas significant increase in the lattice



**Fig. 1** XRD pattern of V doped ZnO samples, where \* represents the impure phase corresponding to  $ZnV_2O_6$

parameter 'c' with increasing the doping concentration (Table 1). This change in lattice parameter values is attributed to larger ionic radii of  $V^{2+}$  (0.93 Å) ions compared to that of the  $Zn^{2+}$  (0.60 Å) ions. Doping V causes distortion in the ZnO crystal structure. Factors like non-uniform distribution of dopants, deviation of V from divalent state may also cause decrease in value of lattice parameter. Similar kinds of behaviour, i.e. decrease in lattice parameter after a particular doping concentration is also reported by other authors (Karamat et al. 2010; Yang et al. 2008).

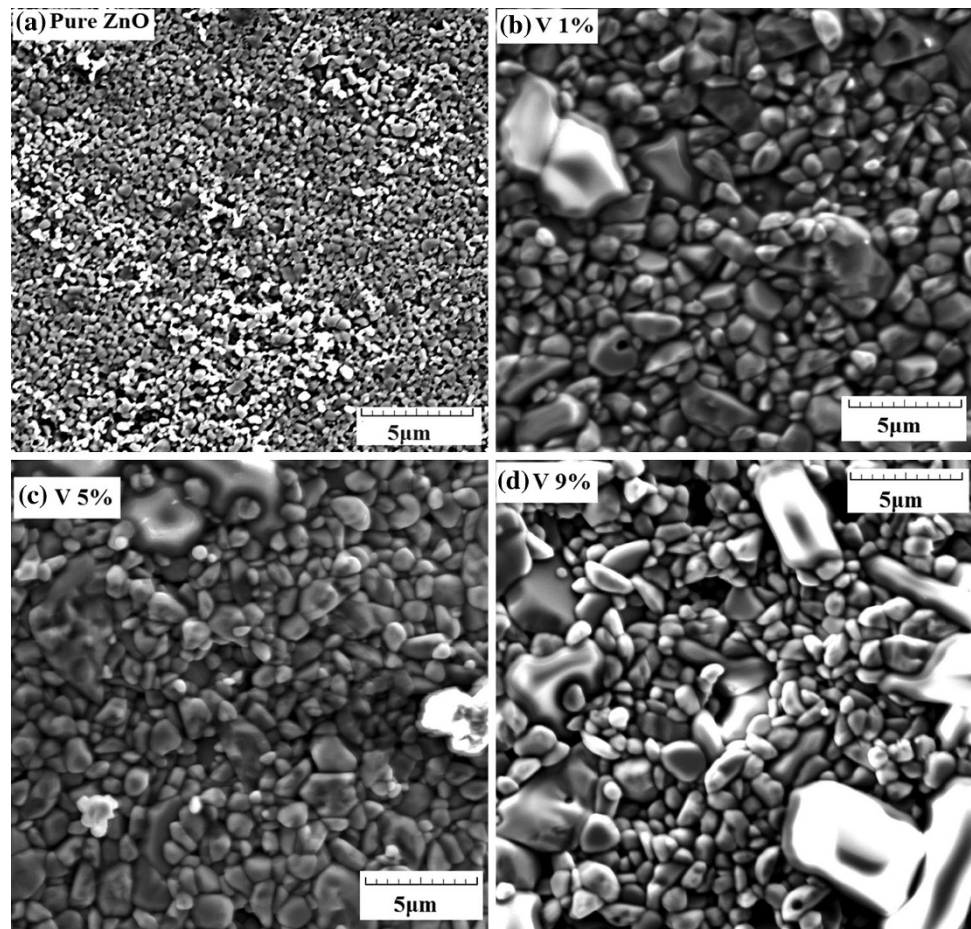
The average crystallite size for all the samples was determined from the broadening of XRD peaks using the Scherer's formula ( $D = 0.89\lambda/\beta \cos \theta$ ). Where  $D$  is crystallite size,  $\beta$  is FWHM and  $\lambda$  is the wavelength of X-rays used. The crystallite size for pure ZnO is estimated to be ~45 nm, which found to be varying from 50 to 60 nm by increasing the V content.

### Scanning electron microscopy SEM

The surface morphology of V doped ZnO with various concentrations examined by SEM are shown in Fig. 2a–d. The average particle size increases with the increase in concentration of V ions. The average particle size for pure ZnO is 0.48 μm and it increase with the increase in V content (~1.3, ~1.9 and ~1.8 μm corresponding to 1, 5 and 9 % V content). For lower concentration (1–5 %), the homogeneity can be seen but for higher concentration inhomogeneous distribution is evident. As doping concentration is large, it causes inhomogeneity and destroys the crystal structure (Wang et al. 2009) as can be observed for 9 % doped sample. There is a large difference in particle size of pure and the 1 % V doped sample which

**Table 1** Parameters for vanadium doped ZnO samples

Composition	$a$ (Å)	$c$ (Å)	$c/a$ ratio	Cell volume (Å <sup>3</sup> )	Band gap (eV)
Pure ZnO	3.2499	5.2038	1.6012	47.59	3.35
1 % V doped ZnO	3.2500	5.2055	1.6016	47.61	3.24
5 % V doped ZnO	3.2512	5.2063	1.6013	47.66	3.25
9 % V doped ZnO	3.2505	5.2059	1.6015	47.63	3.30

**Fig. 2** Scanning Electron Micrographs (SEM) of V doped ZnO samples

indicates that even a small amount of V doping causes a significant change in the morphology. This may be due to the substitution of  $Zn^{2+}$  by V ion, which causes distortion in system and increases the activity of ZnO. This increased activity helps in grain growth and formation of bigger particles in V doped ZnO samples (Colak and Turkoglu 2012). Since the ionic radii mismatch is quite higher in this case, it causes significant increase in the particle size even at very small doping concentration.

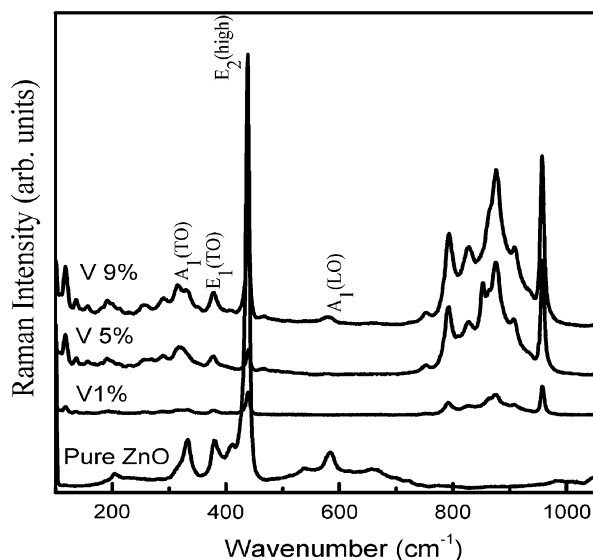
#### Raman spectroscopy

To obtain detailed information about the structural composition of doped samples, Raman spectroscopy measurements were performed. The hexagonal wurtzite ZnO

structure belongs to the space group  $P_63mc$ . The optical phonon mode for ZnO according to the group theory can be expressed as:

$$\Gamma_{\text{Optic}} = A_1 + 2B_1 + E_1 + 2E_2.$$

The modes corresponding to  $A_1$  and  $E_1$  symmetry are polar phonons and are infrared active whereas the  $E_2$  modes are non-polar and Raman active. The  $B_1$  modes are known as the silent modes as these are infrared and Raman inactive. The polar modes exhibit different wave numbers for the transverse optical (TO) and longitudinal optical (LO) phonons. The non-polar phonon modes  $E_2$  split as  $E_2$  (high), associated with oxygen atoms and  $E_2$  (low), associated with Zn sub lattice (Ashkenov et al. 2003; Damen et al. 1966).



**Fig. 3** Raman spectra of V doped ZnO samples

Figure 3 shows the Raman spectra for all the samples in the range of 100–1,000  $\text{cm}^{-1}$ . Several peaks were observed in doped samples at 117, 193, 330, 379, 438, 793, 831, 874, 903, and 957  $\text{cm}^{-1}$ . The peak at 438  $\text{cm}^{-1}$  is the characteristic peak of ZnO which corresponds to the  $E_2$  (high) vibrational mode and band characteristic of wurtzite crystal structure (Youn et al. 2004). It is evident that there are several peaks in addition to the pure ZnO modes. The peaks in the range of 100–330  $\text{cm}^{-1}$  are related to the oxides of V modes and are mostly from the lattice and bending modes of V–O. The peaks in the range of 780–1,000  $\text{cm}^{-1}$  are mainly due to the ZnO and impurity phases of V doping. In lower wave number region, the peak at 330  $\text{cm}^{-1}$  corresponds to transverse optical (TO) phonons of  $A_1$  mode which is second order Raman mode (Samanta et al. 2006). Some defects like oxygen vacancies, Zn interstitials give rise to  $A_1$  mode. On the other hand, the phonons corresponding to the  $E_1$  mode were also observed, the peak at 379  $\text{cm}^{-1}$  corresponds to  $E_1$  (TO) mode.  $A_1$  or  $E_1$  modes in Raman spectra indicate that the lattice vibrations in crystal lattice or in sample are parallel or perpendicular to the  $c$ -axis, respectively. It is also supported by the longitudinal and transverse optical emission of phonons (Youn et al. 2004).

There is a significant shift in peak position at 379 and 439  $\text{cm}^{-1}$  towards lower wave numbers corresponding to  $E_1$  (TO) and  $E_2$  (high) modes, respectively. These modes are characteristic of ZnO and these are also present in V doped ZnO. Some Raman peaks are also observed towards lower frequencies at 136 and 190  $\text{cm}^{-1}$  especially for higher concentration, appear due to the stretching mode of  $(\text{V}_2\text{O}_2)_n$  which correspond to the chain translation (Juloen et al. 1997). The peak at 255  $\text{cm}^{-1}$  is broad in nature and

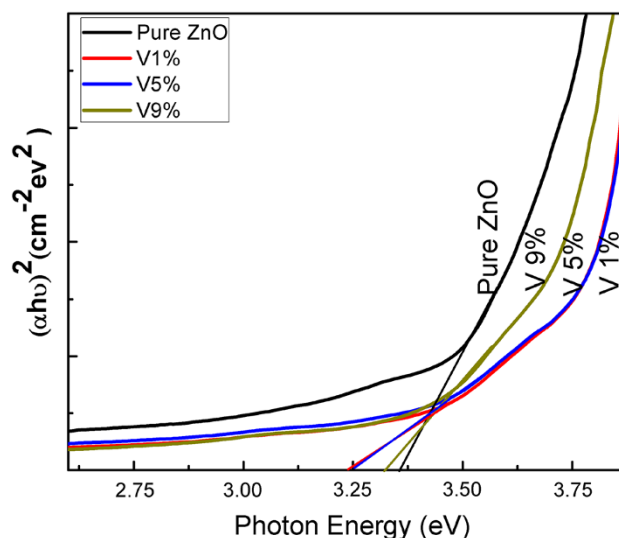
may be due to V–O–V bending mode (Wang et al. 2001). Actually this peak consists of more than one peak. The peak at 315  $\text{cm}^{-1}$  assigned to triply coordinated oxygen ( $\text{V}_3\text{-O}$ ) bond and stretching band (Chen et al. 2004). There are many modes in the wave number range of 750–1,000  $\text{cm}^{-1}$  arise due to V doping in ZnO. The absence of these modes in pure ZnO spectra shows that these modes are associated with the vanadium.

#### UV-Visible spectroscopy

The optical band gap was calculated by extrapolation of linear portion of  $\alpha^2$  versus  $h\nu$  by using the Tauc's relation (Tauc 1971), given by  $(\alpha h\nu) = (h\nu - E_g)^{1/2}$ . Here,  $\alpha$  is the absorption coefficient,  $h\nu$  is the energy of the radiation (photon energy),  $E_g$  is the optical band-gap of the materials. Therefore, the absorption coefficient ( $\alpha$ ) is given by

$$\alpha = 2.303 \log_{10}(A)/t$$

where  $A$  is the absorbance and  $t$  is the thickness of pellets. Figure 4 explains the variation of  $(\alpha h\nu)^2$  versus photon energy ( $h\nu$ ) for all the samples. The band gap for pure ZnO is found to be  $E_g \approx 3.35$  and for V doped ZnO samples of 1, 5 and 9 % V, it is 3.24, 3.25 and 3.30 eV, respectively. It can be seen (Table 1) that the band gap of all the V doped samples is lower than the pure ZnO sample. The reason for this decrease in band gap may be explained on the basis of alloying effect between ZnO and  $\text{V}_2\text{O}_5$ . The band gap of  $\text{V}_2\text{O}_5$  is 2.3 eV and ZnO is 3.37 eV. When  $\text{V}_2\text{O}_5$  is doped in ZnO, mixed oxide of  $\text{ZnV}_2\text{O}_6$  is formed and causes the decrease in the band gap. However, increase in doping concentration led to increase in band gap value which indicates that the Burstein–Moss effect is dominating for higher concentrations.



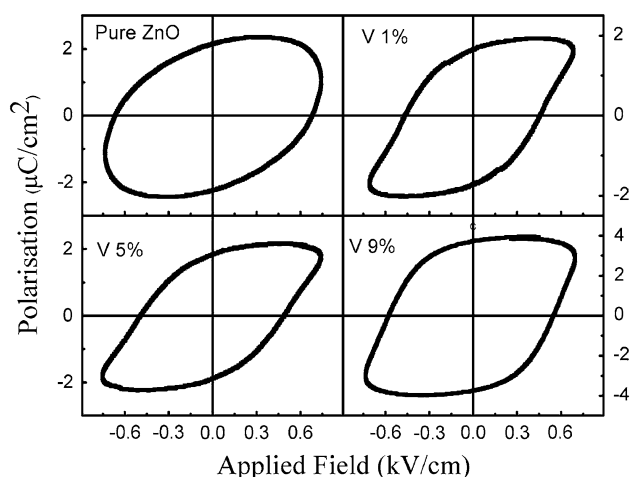
**Fig. 4** Tauc's plot for V doped ZnO samples



It is observed that the band gap of these samples increases with the doping concentration. This might be due to the influence of many factors such as structural parameters, carrier concentrations and presence of defects such as oxygen vacancies which may lead to the Burstein–Moss shift (Yang et al. 2008; Tahir et al. 2009). The Burstein–Moss effect is the process by which the apparent band gap of a semiconductor is increased as the absorption edge is pushed to higher energies as a result of all states close to the conduction band being populated. In Burstein–Moss effect, the Fermi level merges into the conduction band because the addition of V in ZnO contributes electrons to the conduction band. The band gap of pure ZnO is  $E_g \approx 3.35$  and the band gap of V doped ZnO samples is smaller than this and is found to be 3.24, 3.25 and 3.30 eV corresponding to 1, 5 and 9 % V content. The reason for this decrease in band gap may be explained by the alloying effect between  $V_2O_5$  and ZnO. As the band gap of  $V_2O_5$  is 2.3 eV and ZnO is 3.37 eV, when  $V_2O_5$  is doped in ZnO, alloy is formed and causes decrease in band gap. It is clear from Table 1 that for 1 % doping the band gap is lowest, but as the doping concentration increases, the band gap increases instead of decreasing which indicates that the Burstein–Moss effect is dominating for higher concentrations.

#### Ferroelectric hysteresis (P–E loop)

Room temperature ferroelectric hysteresis curves at an applied external field of 5 kV/cm for V doped ZnO are shown in Fig. 5. The hysteresis curves of all samples show loose unsaturated ferroelectric behaviour, however the value of maximum polarization ( $P_{max}$ ) increases with the doping of V in host ZnO from 1.68 to  $3.73 \mu\text{C}/\text{cm}^2$ . The ferroelectric behaviour originates from the dipole orientation. When there is no field applied, the dipoles will have random orientation and as a result there will be no



**Fig. 5** Hysteresis curves of V doped ZnO samples

ferroelectric behaviour. On the other hand with the application of electric field, dipoles align themselves along the field direction resulting in polarization.

In the case of II–VI semiconductors, the ferroelectricity is believed to be originating from the off-centred position of cations. The ionic radii of  $Zn^{2+}$  (0.74 Å) and the dopant ion  $V^{2+}$  (0.93 Å) ions are different. Therefore  $V^{2+}$  ion occupies the off-centred positions and gives rise to permanent local electric dipoles (ferroelectric behaviour) on the application of electric field (Onodera et al. 1996). Apart from off-centred distortion, V substitution on Zn site breaks some Zn–O bonds and formation of new V–O bond takes place. These V–O bonds are non collinear and can rotate easily with the application of external field (Gupta and Kumar 2011). Apart from this, the V–O bond has stronger polar nature than Zn–O (Yang et al. 2007). Therefore the off-centred distortion and the formation of additional V–O bonds will result in the improvement in ferroelectric nature after V incorporation.

#### Conclusions

In summary, we have synthesized the V doped ZnO samples by solid state reaction method and investigated their structural, optical and ferroelectric properties. It has been found that the lattice parameter slightly increases after V doping, indicating partial substitution in host matrix. The shifting in Raman modes of pure ZnO after V incorporation also indicates the presence of V ions in the host matrix. UV–Vis study shows that the band gap of ZnO decreases from 3.35 to 3.24 eV for the 1 % V doped sample. Moreover, P–E loop study reveals that pure ZnO sample exhibit weak ferroelectricity which is slightly improved by V doping.

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